

# MR27V12850L

# 8M-Word $\times$ 16-Bit or 16M-Word $\times$ 8-Bit Page mode P2ROM

## FEATURES

- $\cdot$  8,388,608-word  $\times$  16-bit/16,777,216-word  $\times$  8-bit electrically switchable configuration
- · Page size of 8-word x 16-Bit or 16-word x 8-Bit
- $\cdot$  3.0 V to 3.6 V power supply
- · Access time ...... 85 ns MAX
- · Page Access time ...... 30 ns MAX
- · Operating current ..... 50 mA MAX(5MHz)
- $\cdot$  Standby current ..... 10  $\mu A$  MAX
- · Input/Output TTL compatible
- · Three-state output

## PACKAGES

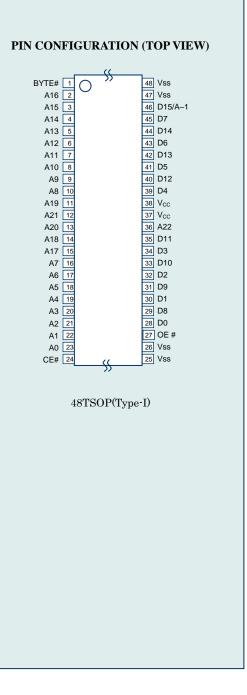
• MR27V12850L-xxxTN 48-pin plastic TSOP (TSOP I 48-P-1220-0.50-1K)

## P2ROM ADVANCED TECHNOLOGY

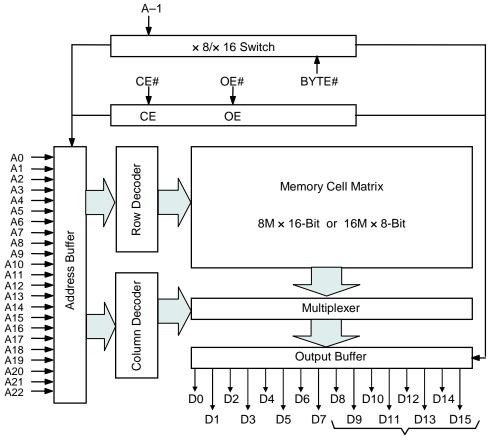
P2ROM stands for Production Programmed ROM. This exclusive LAPIS Semiconductor technology utilizes factory test equipment for programming the customers code into the P2ROM prior to final production testing.

Advancements in this technology allows production costs to be equivalent to MASKROM and has many advantages and added benefits over the other non-volatile technologies, which include the following;

- Short lead time, since the P2ROM is programmed at the final stage of the production process, a large P2ROM inventory "bank system" of un-programmed packaged products are maintained to provide an aggressive lead-time and minimize liability as a custom product.
- No mask charge, since P2ROMs do not utilize a custom mask for storing customer code, no mask charges apply.
- No additional programming charge, unlike Flash and OTP that require additional programming and handling costs, the P2ROM already has the code loaded at the factory with minimal effect on the production throughput. The cost is included in the unit price.
- Custom Marking is available at no additional charge.
- Pin Compatible with Mask ROM



#### **BLOCK DIAGRAM**



In 8-bit output mode, these pins are placed in a high-Z state and pin D15 functions as the A-1 address pin.

#### **PIN DESCRIPTIONS**

Pin name	Functions	
D15 / A–1	Data output / Address input	
A0 to A22	Address inputs	
D0 to D14	Data outputs	
CE#	Chip enable input	
OE#	Output enable input	
BYTE#	Word / Byte select input	
V <sub>CC</sub>	Power supply voltage	
V <sub>SS</sub>	Ground	

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#### MR27V12850L / P2ROM

## **FUNCTION TABLE**

Mode	CE#	OE#	BYTE#	V <sub>CC</sub>	D0 to D7	D8 to D14	D15/A–1
Read (16-Bit)	L	L	Н			D <sub>OUT</sub>	
Read (8-Bit)	L	L	L		D <sub>OUT</sub>	Hi–Z	L/H
Output dis shite			Н	3.0 V	11: 7		
Output disable	L	Н	L	to 3.6 V		Hi–Z	*
Standby	н	*	Н		11: 7		
		*	L			Hi–Z	*

\*: Don't Care (H or L)

#### ABSOLUTE MAXIMUM RATINGS

Parameter	Symbol	Condition	Value	Unit
Operating temperature under bias	Та		0 to 70	°C
Storage temperature	Tstg	_	-55 to 125	°C
Input voltage	VI		-0.5 to V <sub>CC</sub> +0.5	V
Output voltage	Vo	relative to $V_{SS}$	–0.5 to V <sub>CC</sub> +0.5	V
Power supply voltage	V <sub>cc</sub>		–0.5 to 5	V
Power dissipation per package	PD	Ta = 25°C	1.0	W
Output short circuit current	I <sub>OS</sub>	—	10	mA

## **RECOMMENDED OPERATING CONDITIONS**

(Ta = 0 to 70°C)

Parameter	Symbol	Condition	Min.	Тур.	Max.	Unit
V <sub>CC</sub> power supply voltage	V <sub>CC</sub>		3.0	—	3.6	V
Input "H" level	VIH	$V_{CC}$ = 3.0 to 3.6 V	2.2	—	V <sub>CC</sub> +0.5*	V
Input "L" level	VIL		-0.5**	—	0.6	V

Voltage is relative to  $V_{SS}$ .

\* : Vcc+1.5V(Max.) when pulse width of overshoot is less than 10ns.

\*\* : -1.5V(Min.) when pulse width of undershoot is less than 10ns.

## PIN CAPACITANCE

				(V <sub>CC</sub> = 3.	.0 V, Ta = 25°	C, f = 1 MHz)
Parameter	Symbol	Condition	Min.	Тур.	Max.	Unit
Input	C <sub>IN1</sub>		—	—	10	
BYTE#	C <sub>IN2</sub>	$V_1 = 0 V$	_	—	200	pF
Output	COUT	$V_{O} = 0 V$	—	—	10	

## **ELECTRICAL CHARACTERISTICS**

#### **DC CHARACTERISTICS**

				$(V_{CC} = 3.0)$	to 3.6 V, Ta	= 0 to 70°C)
Parameter	Symbol	Condition	Min.	Тур.	Max.	Unit
Input leakage current	ILI	$V_1 = 0$ to $V_{CC}$	—	—	10	μA
Output leakage current	I <sub>LO</sub>	$V_{O} = 0$ to $V_{CC}$	—	—	10	μA
V <sub>CC</sub> power supply current	I <sub>CCSC</sub>	$CE\# = V_{CC}$	—	—	10	μA
(Standby)	I <sub>CCST</sub>	$CE\# = V_{IH}$	—	—	1	mA
V <sub>CC</sub> power supply current (Read)	I <sub>CCA</sub>	$CE\# = V_{IL}, OE\# = V_{IH}$ f=5MHz	—	—	50	mA
Input "H" level	V <sub>IH</sub>	—	2.2	—	V <sub>CC</sub> +0.5*	V
Input "L" level	V <sub>IL</sub>	—	-0.5**	—	0.6	V
Output "H" level	V <sub>OH</sub>	I <sub>OH</sub> = -1 mA	2.4	_	_	V
Output "L" level	Vol	$I_{OL} = 2 \text{ mA}$	_	_	0.4	V

Voltage is relative to V<sub>SS</sub>.

\* : Vcc+1.5V(Max.) when pulse width of overshoot is less than 10ns.

\*\* : -1.5V(Min.) when pulse width of undershoot is less than 10ns.

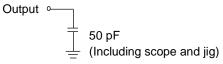
## AC CHARACTERISTICS

			(V <sub>CC</sub>	= 3.0 to 3.6 V, Ta	= 0 to 70°C)
Parameter	Symbol	Condition	Min.	Max.	Unit
Address cycle time	t <sub>C</sub>	—	85	—	ns
Address access time	t <sub>ACC</sub>	$CE\# = OE\# = V_{IL}$	—	85	ns
Page cycle time	t <sub>PC</sub>	—	30	—	ns
Page access time	t <sub>PAC</sub>	—	—	30	ns
CE# access time	t <sub>CE</sub>	$OE\# = V_{IL}$	—	85	ns
OE# access time	t <sub>OE</sub>	$CE\# = V_{IL}$	—	30	ns
Output disable time	t <sub>CHZ</sub>	$OE\# = V_{IL}$	0	20	ns
	t <sub>OHZ</sub>	$CE\# = V_{IL}$	0	20	ns
Output hold time	t <sub>OH</sub>	$CE\# = OE\# = V_{IL}$	0	—	ns

Measurement conditions

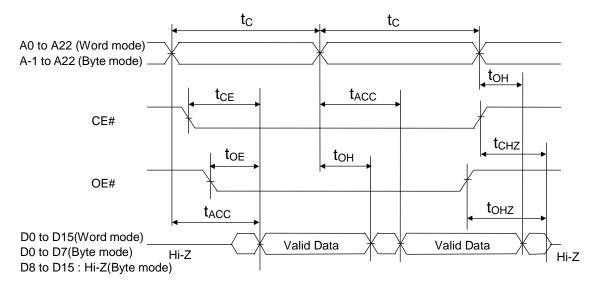
Input signal level	0 V/3 V
Input timing reference level	1/2Vcc
Output load	50 pF
Output timing reference level	1/2Vcc

Output load

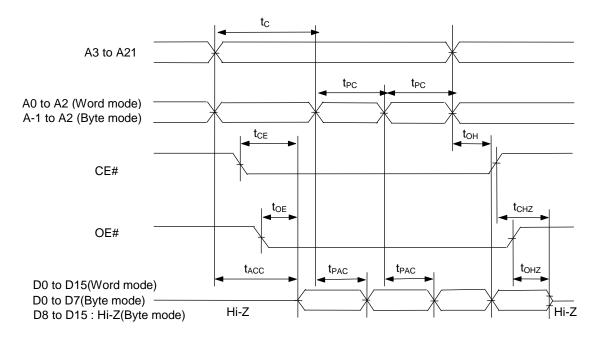


## TIMING CHART (READ CYCLE)

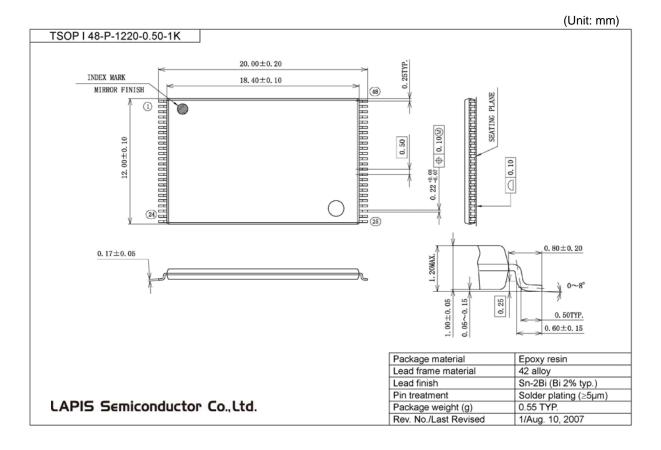
## RANDOM ACCESS MODE READ CYCLE



PAGE ACCESS MODE READ CYCLE



#### PACKAGE DIMENSIONS



#### Notes for Mounting the Surface Mount Type Package

The surface mount type packages are very susceptible to heat in reflow mounting and humidity absorbed in storage. Therefore, before you perform reflow mounting, contact ROHM's responsible sales person for the product name, package name, pin number, package code and desired mounting conditions (reflow method, temperature and times).

## **REVISION HISTORY**

Document		Page			
No.	Date	Previous Edition	Current Edition	Description	
FEDR27V12850L-02-01	May.9, 2005	-	-	Final edition 1	
		1, 4	1, 4	Change tC, tACC, tCE to 85ns	
FEDR27V12850L-002-02	Jan.6, 2009	_	_	Changed company logo and name to OKI SEMICONDUCTOR	

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